

**Notice of References Cited**

Application/Control No.

09/998,225

Applicant(s)/Patent Under

Reexamination

ABE ET AL.

Examiner

Kuen S Lu

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0037325	11-2001	Biderman et al.	707/1
*	B	US-6,487,641	11-2002	Cusson et al.	711/144
*	C	US-6,487,566	11-2002	Sundaresan, Neelakantan	715/513
*	D	US-6,029,165	02-2000	Gable, Gary A.	707/3
*	E	US-6,385,605	05-2002	Suzuoka et al.	707/4
*	F	US-6,526,400	02-2003	Takata et al.	707/3
*	G	US-6,584,465	06-2003	Zhu et al.	707/6
*	H	US-6,493,705	12-2002	Kobayashi et al.	707/3
*	I	US-6,094,647	07-2000	Kato et al.	707/2
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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